

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Hirohito OKUDA et al.  
Serial No.: 10/809,464  
Filed: March 26, 2004  
Title: APPARATUS AND METHOD FOR CLASSIFYING DEFECTS  
USING MULTIPLE CLASSIFICATION MODULES (as amended)  
Group: 2624  
Examiner: Edward PARK  
Confirmation No.: 7643

**AMENDMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

June 20, 2008

Sir:

In response to the Office Action dated February 20, 2008, the period of response for which extension of time is requested in the attached Petition for Extension of Time, and concurrently filed in connection with a Request for Continued Examination (RCE), please amend the above-identified application as listed below and as set forth on the following pages:

**Amendments** to the specification are included on page 2;

**Amendments** to the claims begin on page 3;

**Remarks** are included beginning on page 7; and

**Authorization** is included on page 14.